

2SK3566

Switching Regulator Applications

Unit: mm

• Low drain-source ON-resistance: $R_{DS (ON)} = 5.6 \Omega (typ.)$

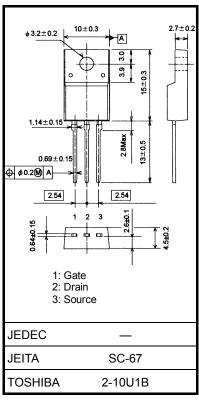
• High forward transfer admittance: |Y_{fs}| = 2.0 S (typ.)

• Low leakage current: $I_{DSS} = 100 \mu A (max) (V_{DS} = 720 V)$

• Enhancement mode: V_{th} = 2.0 to 4.0 V (V_{DS} = 10 V, I_D = 1 mA)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics			Symbol	Rating	Unit	
Drain-source voltage			V_{DSS}	900	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)			V_{DGR}	900	V	
Gate-source voltage			V _{GSS}	±30	V	
Drain current	DC	(Note 1)	I _D	2.5		
	Pulse	(t = 1 ms) (Note 1)	I _{DP}	7.5	Α	
Drain power dissipation (Tc = 25°C)			P _D	40	W	
Single pulse avalanche energy (Note 2)			E _{AS}	216	mJ	
Avalanche current			I _{AR}	2.5	Α	
Repetitive avalanche energy (Note 3)			E _{AR}	4	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature range			T _{stg}	-55 to 150	°C	

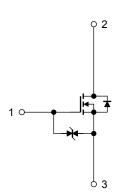


Weight: 1.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	3.125	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W



Note 1: Please use devices on conditions that the channel temperature is below 150°C.

Note 2: $V_{DD} = 90 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$, L = 63.4 mH, $I_{AR} = 2.5 \text{ A}$, $R_G = 25 \Omega$

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μΑ
Gate-source brea	akdown voltage	V (BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-off current		I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	900	_	_	V
Gate threshold voltage		V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON-resistance		R _{DS} (ON)	V _{GS} = 10 V, I _D = 1.5 A	_	5.6	6.4	Ω
Forward transfer admittance		Yfs	V _{DS} = 20 V, I _D = 1.5 A	1.0	2.0	_	S
Input capacitance		C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	470	_	pF
Reverse transfer capacitance		C _{rss}			10	_	
Output capacitance		Coss		_	50	_	
Switching time	Rise time	t _r	10 V ID = 1.5 A VOUT VGS 0 V RL = 133 Ω	_	20	_	- ns
	Turn-on time	t _{on}		_	60	_	
	Fall time	t _f	V _{DD} ≈ 200 V	_	30	_	
	Turn-off time	t _{off}	Duty \leq 1%, $t_W = 10 \mu s$	_	100	_	
Total gate charge		Qg		_	12	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$	_	7	_	nC
Gate-drain charge		Q _{gd}			5		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	2.5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	7.5	Α
Forward voltage (diode)	V _{DSF}	$I_{DR} = 2.5 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time	t _{rr}	$I_{DR} = 2.5 \text{ A}, V_{GS} = 0 \text{ V},$	_	720	_	ns
Reverse recovery charge	Q _{rr}	dI _{DR} /dt = 100 A/μs		3.6	_	μС

Marking

